



N-channel 1050 V, 6 Ω typ., 1.5 A Zener-protected SuperMESH™ 5 Power MOSFET in a TO-3PF package

Datasheet - preliminary data

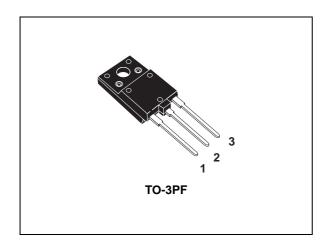
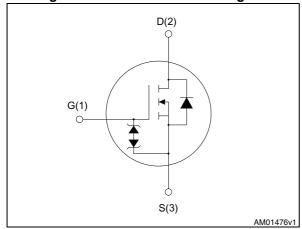


Figure 1. Internal schematic diagram



Features

Order code	V_{DS}	R _{DS(on)} max	I _D	P _{TOT}
STFW2N105K5	1050 V	8 Ω	1.5 A	30 W

- Worldwide best FOM (figure of merit)
- Ultra low gate charge
- 100% avalanche tested
- Zener-protected

Applications

• Switching applications

Description

This N-channel Zener-protected Power MOSFET is designed using ST's revolutionary avalancherugged very high voltage SuperMESH™ 5 technology, based on an innovative proprietary vertical structure. The result is a dramatic reduction in on-resistance, and ultra-low gate charge for applications which require superior power density and high efficiency.

Table 1. Device summary

Order code	Marking	Package	Packaging
STFW2N105K5	2N105K5	TO-3PF	Tube

Contents STFW2N105K5

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STFW2N105K5 Electrical ratings

1 Electrical ratings

Table 2. Absolute maximum ratings

Symbol	Parameter	Value	Unit
V _{GS}	Gate- source voltage	30	V
I _D	Drain current (continuous) at T _C = 25 °C	2 ⁽¹⁾	Α
I _D	Drain current (continuous) at T _C = 100 °C	1.3 ⁽¹⁾	Α
I _{DM}	Drain current (pulsed)	6	Α
P _{TOT}	Total dissipation at T _C = 25 °C	30	W
I _{AR}	Max current during repetitive or single pulse avalanche	0.5	Α
E _{AS}	Single pulse avalanche energy (starting $T_J = 25$ °C, $I_D = I_{AS}$, $V_{DD} = 50$ V)	90	mJ
dv/dt (2)	Peak diode recovery voltage slope	4.5	V/ns
dv/dt ⁽³⁾	MOSFET dv/dt ruggedness	50	V/ns
V _{ISO}	Insulation withstand voltage (RMS) from all three leads to external heat sink (t=1 s; TC=25 °C)	3500	V
T _j T _{stg}			°C

^{1.} Pulse width limited by safe operating area.

Table 3. Thermal data

Symbol	Parameter	Value	Unit
R _{thj-case}	Thermal resistance junction-case max	4.2	°C/W
R _{thj-amb}	Thermal resistance junction-ambient max	50	°C/W

^{2.} $I_{SD} \leq$ 1.5 A, di/dt \leq 100 A/ μ s, $V_{Peak} \leq V_{(BR)DSS}$.

^{3.} $V_{SD} \le 840 \text{ V}$

Electrical characteristics STFW2N105K5

2 Electrical characteristics

(Tcase =25 °C unless otherwise specified)

Table 4. On /off states

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V _{(BR)DSS}	Drain-source breakdown voltage	I _D = 1 mA, V _{GS} = 0	1050			٧
1	Zero gate voltage, drain current (V _{GS} = 0)	V _{DS} = 1050 V			1	μΑ
DSS		V _{DS} = 1050 V, T _C =125 °C			50	μΑ
I _{GSS}	Gate-body leakage current	$V_{GS} = \pm 20 \text{ V; } V_{DS} = 0$			10	μΑ
V _{GS(th)}	Gate threshold voltage	$V_{DS} = V_{GS}, I_{D} = 100 \mu A$	3	4	5	٧
R _{DS(on)}	Static drain-source on- resistance	V _{GS} = 10 V, I _D = 0.75 A		6	8	Ω

Table 5. Dynamic

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
C _{iss}	Input capacitance		-	115	-	pF
C _{oss}	Output capacitance	V _{DS} =100 V, f=1 MHz, V _{GS} =0	ı	15	-	pF
C _{rss}	Reverse transfer capacitance	V _{DS} = 100 V, 1=1 IVII 12, V _{GS} =0	-	0.5	1	pF
C _{o(tr)} ⁽¹⁾	Equivalent capacitance time related	$V_{GS} = 0$, $V_{DS} = 0$ to 840 V	-	17	-	pF
C _{o(er)} ⁽²⁾	Equivalent capacitance energy related		-	6	-	pF
R _G	Intrinsic gate resistance	f = 1 MHz open drain	-	20	-	Ω
Qg	Total gate charge	V _{DD} = 840 V, I _D = 1.5 A V _{GS} =10 V	-	10	-	nC
Q _{gs}	Gate-source charge		ı	1.5	-	nC
Q_{gd}	Gate-drain charge	(see Figure 16)	-	8	-	nC

^{1.} Time related is defined as a constant equivalent capacitance giving the same charging time as C_{oss} when V_{DS} increases from 0 to 80% V_{DSS}

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^{2.} energy related is defined as a constant equivalent capacitance giving the same stored energy as C_{oss} when V_{DS} increases from 0 to 80% V_{DSS}

Table 6. Switching times

Symbol	Parameter	Test conditions	Min.	Тур.	Max	Unit
t _{d(on)}	Turn-on delay time		-	14.5	-	ns
t _r	Rise time	$V_{DD} = 525 \text{ V}, I_D = 0.75 \text{ A},$ $R_G = 4.7 \Omega, V_{GS} = 10 \text{ V}$	-	8.5	-	ns
t _{d(off)}	Turn-off-delay time	n _G = 4.7 52, v _{GS} = 10 v (see Figure 15)	-	35	-	ns
t _f	Fall time		-	38.5	-	ns

Table 7. Source drain diode

Symbol	Parameter	Test conditions	Min.	Тур.	Max	Unit
I _{SD}	Source-drain current		-		1.5	Α
I _{SDM} ⁽¹⁾	Source-drain current (pulsed)		-		6	Α
V _{SD} (2)	Forward on voltage	$I_{SD} = 1.5 \text{ A}, V_{GS} = 0$	-		1.5	٧
t _{rr}	Reverse recovery time	$I_{SD} = 1.5 \text{ A, di/dt} = 100 \text{ A/}\mu\text{s}$	-	326		ns
Q _{rr}	Reverse recovery charge	V _{DD} = 60 V	-	1.19		μC
I _{RRM}	Reverse recovery current	(see Figure 17)	-	7.3		Α
t _{rr}	Reverse recovery time	$I_{SD} = 1.5 \text{ A, di/dt} = 100 \text{ A/}\mu\text{s}$	-	525		ns
Q _{rr}	Reverse recovery charge	V _{DD} = 60 V T _J = 150 °C	-	1.83		μC
I _{RRM}	Reverse recovery current	(see Figure 17)	-	7		Α

^{1.} Pulse width limited by safe operating area

Table 8. Gate-source Zener diode

Symbol	Parameter	Test conditions	Min	Тур.	Max.	Unit
V _{(BR)GSO}	Gate-source breakdown voltage	$I_{GS} = \pm 1 \text{mA}, I_D = 0$	30	-	-	V

The built-in back-to-back Zener diodes have specifically been designed to enhance the device's ESD capability. In this respect the Zener voltage is appropriate to achieve an efficient and cost-effective intervention to protect the device's integrity. These integrated Zener diodes thus avoid the usage of external components.

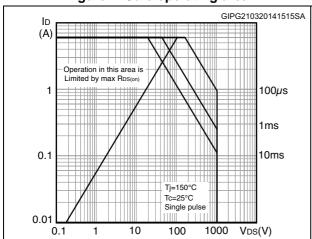
^{2.} Pulsed: pulse duration = 300 μ s, duty cycle 1.5%

Electrical characteristics STFW2N105K5

2.1 Electrical characteristics (curves)

Figure 2. Safe operating area

Figure 3. Thermal impedance



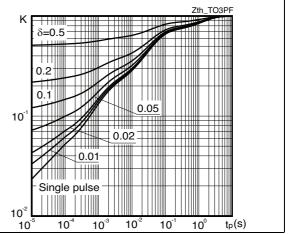
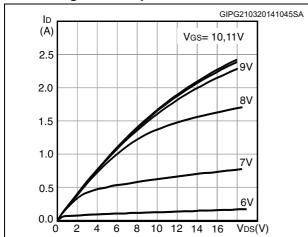


Figure 4. Output characteristics

Figure 5. Transfer characteristics



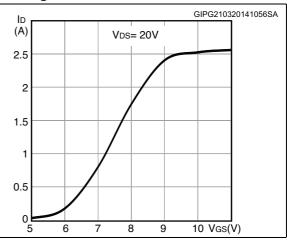
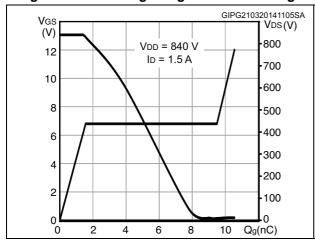


Figure 6. Gate charge vs gate-source voltage

Figure 7. Static drain-source on-resistance



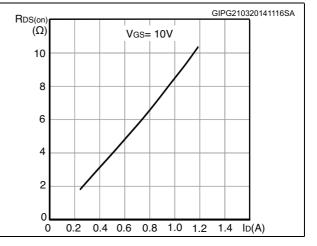
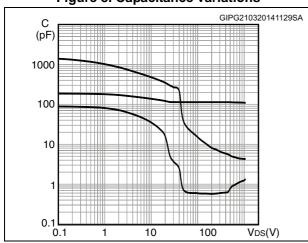


Figure 8. Capacitance variations

Figure 9. Output capacitance stored energy



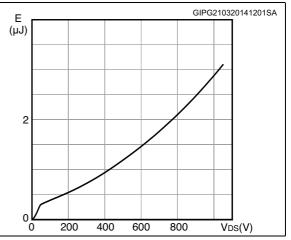
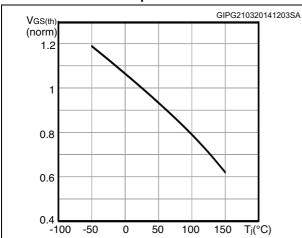


Figure 10. Normalized gate threshold voltage vs temperature

Figure 11. Normalized on-resistance vs temperature



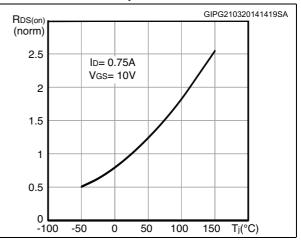
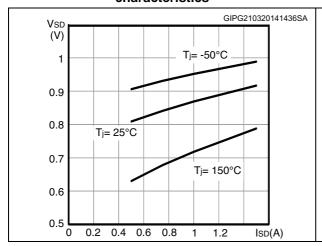
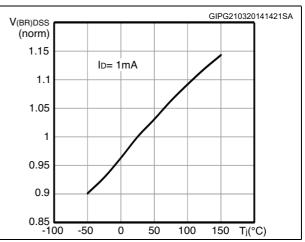


Figure 12. Source-drain diode forward characteristics

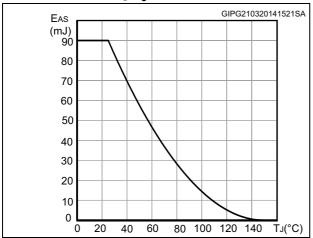
Figure 13. Normalized $V_{(BR)DSS}$ vs temperature





Electrical characteristics STFW2N105K5

Figure 14. Maximum avalanche energy vs starting $\mathbf{T}_{\mathbf{J}}$



STFW2N105K5 Test circuits

3 Test circuits

Figure 15. Switching times test circuit for resistive load

Figure 16. Gate charge test circuit

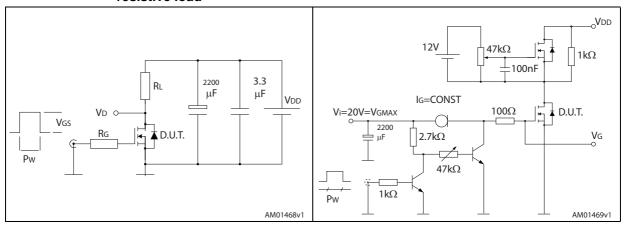


Figure 17. Test circuit for inductive load switching and diode recovery times

Figure 18. Unclamped inductive load test circuit

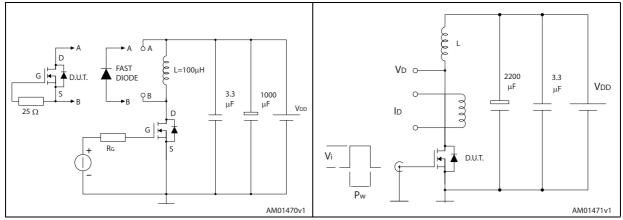
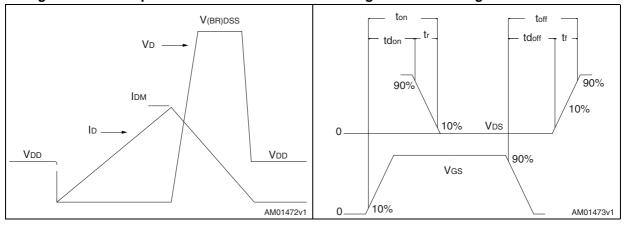


Figure 19. Unclamped inductive waveform

Figure 20. Switching time waveform



4 Package mechanical data

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Figure 21. TO-3PF drawing

Table 9. TO-3PF mechanical data

Dim		mm	
Dim.	Min.	Тур.	Max.
Α	5.30		5.70
С	2.80		3.20
D	3.10		3.50
D1	1.80		2.20
E	0.80		1.10
F	0.65		0.95
F2	1.80		2.20
G	10.30		11.50
G1		5.45	
Н	15.30		15.70
L	9.80	10	10.20
L2	22.80		23.20
L3	26.30		26.70
L4	43.20		44.40
L5	4.30		4.70
L6	24.30		24.70
L7	14.60		15
N	1.80		2.20
R	3.80		4.20
Dia	3.40		3.80

STFW2N105K5 Revision history

5 Revision history

Table 10. Document revision history

Date	Revision	Changes
08-May-2014	1	First release.

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